SPECIFICATIONS FOR UPEC LAMP TYPE **RED** LED

MODEL: UE-LR800NR0-1XC

UPEC ELECTRONICS CORPORATION



Part NO.	Chip Material	Lens Color	Source Color
UE-LR800NR0-1XC	AlGaInP	Water Clear	Red

Notes

- 1. All dimensions are in millimeters (inches).
- 2. Tolerance is ±0.25mm (.010") unless otherwise noted.
- 3. Protruded resin under flange is 1.0mm (.04") max.
- 4. Lead spacing is measured where the leads emerge from the package.
- 5. Specifications are subject to change without notice.
- 6. Precautions for ESD:

STATIC SHIELD Electricity and surge damages the LED. It is recommended to use a wrist band or anti-electrostatic glove when handling the LED. All devices, equipment and machinery must be properly grounded.

7. This data-sheet only valid for six months.

			Approved	Checked	Symbol	UPEC LED
					Nomo	UE-LR800NR0-1XC
			Justin Tsa	T !	ivame	
-	JUN/07/04			Isai	Drawing No	WIENDS197
Mark	Date	Description Approve				

Absolute Maximum Ratings at Ta=25			
Parameter	Symbol	Max	Unit
Power Dissipation	PD	100	mW
Pulse Forward Current	IPF	100	mA
Forward Current	lF	35	mA
Reverse Voltage	VR	5	V
Operating Temperature Range	Topr	- 40 to + 80	°C
Storage Temperature Range	Tstg	- 40 to + 80	°C
Lead Soldering Temperature [1.6mm (0.063inch) From	Body 1 260 °C For 5 Second	ds	

Electrical / Optical Characteristics at Ta=25

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Condition
Luminous Intensity	lv	2200	7000	14000	mcd	l _f =20mA (Note 1)
Viewing Angle	2 θ _{1/2}		20		Deg	(Note 2)
Dominant Wavelength	λd		625		nm	l _f =20mA (Note 3)
Forward Voltage	V _F		2.2	2.7	V	lF = 20mA
Reverse Current	I _R			100	μA	VR = 5V

BIN	LR	LS	LT	LU	LV	
Range	2200-3300	3300-4900	4900-7300	7300-11000	11000-16500	

Measurement Uncertainty of the Luminous Intensity: ± 15%

Notes

- 1. Luminous intensity is measured with a light sensor and filter combination that approximates the CIE eye-response curve.
- 2. $\theta_{1/2}$ is the off-axis angle at which the luminous intensity is half the axial luminous intensity.
- 3. The dominant wavelength (λ d) is derived from the CIE chromaticity diagram and represents the single wavelength which defines the color of the device.

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1 Solder Heat TEMP : 260 ±5 5 sec 22 2 Temperature Cycle \(\sigma\) 5min. 50 cycle 22 2 Temperature Cycle \(\sigma\) 5min. 50 cycle 22 2 Temperature Cycle \(\sigma\) 5min. 50 cycle 22 3 Thermal Shock \(\sigma\) 5min. 50 cycle 22 4 High Temperature Storage TEMP : 85 1000 hrs 22 5 Low Temperature Storage TEMP : -35 1000 hrs 22 6 DC Operating Life I _F =20mA 1000 hrs 22 7 High Temperature /High Humidity 65 /85~90%R.H. 1000 hrs 22		Sample Q'ty	Test Hours / Cycle	Test Conditions	ltem	No.
2 Temperature Cycle ↓ : +85 30min. 50 cycle 22 2 Temperature Cycle ↓ 5min. 50 cycle 22 L : -35 30min. H : +85 50 cycle 22 3 Thermal Shock ↓ 5min. 50 cycle 22 4 High Temperature Storage TEMP : 85 1000 hrs 22 5 Low Temperature Storage TEMP : -35 1000 hrs 22 6 DC Operating Life I _F =20mA 1000 hrs 22 7 High Temperature / High Humidity 65 /85~90%R.H. 1000 hrs 22 Judgment Criteria	2 pcs 0/1	22 pcs	5 sec	TEMP: 260 ±5	Solder Heat	1
2 Temperature Cycle ∫ 5min. 50 cycle 22 L:-35 30min. L:-35 30min. H:+85 J				H : +85 30min.		
L: -35 30min.3Thermal ShockH: +85 √ 5min.50 cycle22 22 24High Temperature StorageTEMP : 851000 hrs22 225Low Temperature StorageTEMP : -351000 hrs22 226DC Operating LifeI _F =20mA1000 hrs22 227High Temperature /High Humidity65 /85~90%R.H.1000 hrs22 22	2 pcs 0/1	22 pcs	50 cycle	∫ 5min.	Temperature Cycle	2
3 Thermal Shock \(\sum 5\) 50 cycle 22 3 Thermal Shock \(\sum 5\) 50 ini. 50 cycle 22 4 High Temperature Storage TEMP : 85 1000 hrs 22 5 Low Temperature Storage TEMP : -35 1000 hrs 22 6 DC Operating Life IF=20mA 1000 hrs 22 7 High Temperature / High Humidity 65 /85~90% R.H. 1000 hrs 22 Judgment Criteria				L:-35 30min.		
3 Thermal Shock \$\sqrt{5min.}\$ 50 cycle 22 4 High Temperature Storage TEMP : 85 1000 hrs 22 5 Low Temperature Storage TEMP : -35 1000 hrs 22 6 DC Operating Life I _F =20mA 1000 hrs 22 7 High Temperature / High Humidity 65 /85~90%R.H. 1000 hrs 22 Judgment Criteria				H:+85		
L: -35 5min.4High Temperature StorageTEMP : 851000 hrs225Low Temperature StorageTEMP : -351000 hrs226DC Operating LifeIF=20mA1000 hrs227High Temperature / High Humidity65 /85~90%R.H.1000 hrs22Judgment Criteria	2 pcs 0/1	22 pcs	50 cycle	∫ 5min.	Thermal Shock	3
4 High Temperature Storage TEMP : 85 1000 hrs 22 5 Low Temperature Storage TEMP : -35 1000 hrs 22 6 DC Operating Life IF=20mA 1000 hrs 22 7 High Temperature / High Humidity 65 /85~90%R.H. 1000 hrs 22 Judgment Criteria				L:-35 5min.		
5 Low Temperature Storage TEMP : -35 1000 hrs 22 6 DC Operating Life IF=20mA 1000 hrs 22 7 High Temperature / High Humidity 65 /85~90%R.H. 1000 hrs 22 Judgment Criteria	2 pcs 0/1	22 pcs	1000 hrs	TEMP : 85	High Temperature Storage	4
6 DC Operating Life I _F =20mA 1000 hrs 22 7 High Temperature / High Humidity 65 /85~90%R.H. 1000 hrs 22 Judgment Criteria	2 pcs 0/1	22 pcs	1000 hrs	TEMP:-35	Low Temperature Storage	5
7 High Temperature / High Humidity 65 /85~90%R.H. 1000 hrs 22 Judgment Criteria	2 pcs 0/1	22 pcs	1000 hrs	I _F =20mA	DC Operating Life	6
Judgment Criteria	2 pcs 0/1	22 pcs	1000 hrs	65 /85~90%R.H.	High Temperature / High Humidity	7
				Judgment Criteria		
Forward Voltage Vf Vf _{max} Increase <1.2x	x	e <1.2x	Vf _{max} Increase		Forward Voltage Vf	
Reverse Current Ir Ir _{max} Increase <2x		se <2x	Ir _{max} Increas		Reverse Current Ir	
Luminous Intensity Iv Iv Decay < 50%		50%	lv Decay <		Luminous Intensity lv	
Note:Measurement shall be taken after the tested samples have been returned to normal aml	nbient conditions	mal ambient co	been returned to nor	e tested samples have	e:Measurement shall be taken after th	Note
(generally after two hours)					erally after two hours)	(gen

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